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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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09/757,529

01/11/2001

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018775-814

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02/22/2005

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EXAMINER

DASTOURI, MEHRDAD

ART UNIT

PAPER NUMBER

2623

DATE MAILED: 02/22/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/757,529

Applicant(s)

MORI, TOSHIHIRO

Examiner

Mehrdad Dastouri

Art Unit

2623

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on November 10, 2004.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 16-26 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 16-26 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☐ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on November 10, 2004 has been entered.

Response to Amendment

2. Applicant's amendment filed August 19, 2004, has been entered and made of record.

Response to Arguments

3. Applicant's arguments have been fully considered but they are moot in view of new grounds of rejection.

Specification

4. Objection to the specification has been withdrawn in view of Applicant's amendment.

Drawings

5. Objection to the specification has been withdrawn in view of Applicant's correction and submittal of the replacement and annotated sheet.

Claim Rejections - 35 USC § 102

6. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

7. Claims 16, 17 and 20-26 are rejected under 35 U.S.C. 102(e) as being anticipated by Maruo (U.S. 6,292,583).

Regarding Claim 16, Maruo discloses a specified pattern recognition apparatus comprising:

a plurality of filters provided for detecting an image at a first resolution (Figure 1, Step S1, Two-dimensional wavelet-transform; Column 6, Lines 57-67, Column 7, Lines 1-51. Wavelet transform comprises a plurality of low-pass and high –pass filtering.);

an extractor which extracts a specified pattern included in the image with use of a combination of filters in said plurality of filters to determine a position of the specified pattern (Figures 5 and 6; Column 7, Lines 34-51. Edge components of the input signal have been extracted by wavelet transformation.);

a circuit for generating an image of the specified pattern at a resolution lower than the first resolution (Figure 1, Step S2, Binarization Process. In addition to the different lower resolution images generated by the wavelet transform, binarization process will further generate an image of lower optical resolution.):

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a calculator which determines the position of the specified pattern more precisely than said extractor, based on the position determined by said extractor and the lower resolution image (Figure 1, Step S3, Hough-Transform; Column 5, Lines 59-63; Column 6, Lines 3-56).

With regards to Claim 17, arguments analogous to those presented for Claim 16 are applicable to Claim 17. Maruo further discloses:

an image extractor which extracts partial images included in the specified pattern, in the bi-level image data obtained by said binarizer (Figures 3, 7 and 8; Column 8, Lines 30-57. The circle is the extracted partial image.);

a reduced image generator which generates a reduced image of an image including the specified partial image, the reduced image having a lower resolution than the image including the specified images (Figures 8 and 15, Wavelet transform inherently generates lower resolution image of the specified partial image (The circle)).

Regarding Claim 20, Maruo further discloses the specified pattern detection apparatus according to Claim 16, wherein the plurality of filters are providing for extracting a plurality of specified patterns (Figures 5 and 6; Column 7, Lines 34-51. Edge components of the input signal have been extracted by wavelet transformation.).

With regards to Claim 21, arguments analogous to those presented for Claim 20 are applicable to Claim 21.

With regards to Claim 22, arguments analogous to those presented for Claim 16 are applicable to Claim 22.

With regards to Claim 23, arguments analogous to those presented for Claim 17 are applicable to Claim 23.

Regarding Claim 24, Maruo discloses a specified pattern detection apparatus comprising:

a binarizer which binarizes input image data to provide bi-level image data (Figures 1 and 2, Binarization process; Column 5, Lines 57-67, Column 6, Lines 1-5);

a storage device which stores the bi-level image data obtained by said binarizer (Figure 11, RAM 34);

a partial image extractor which extracts specified partial images in the bi-level image stored in said storage device with a filter for conversion (Figures 1 and 2, Hough transform; Column 6, Lines 5-6);

a gain calculator which calculates and stores information for each pixel in the bi-level image, in which the specified partial images are extracted, with a gain filter, the information representing a distance from the each pixel to the specified partial image (Column 6, Lines 5-20; Formulas (1) and (2));

a position calculator which calculates ideal positions of the partial images to be included in a specified pattern (Column 6, Lines 22-56; Column 9, Lines 12-23; Figure 3A; Column 10, Lines 46-67, Column 11, Lines 1-21; Column 13, Lines 23-51); and

a gain output device which outputs a gain on the ideal positions based on the information obtained and stored by said gain calculator (Figure 3A; Column 10, Lines 46-67, Column 11, Lines 1-21).

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Regarding Claim 25, Maruo further discloses the specified pattern detection apparatus according to Claim 24, wherein said conversion filter converts the partial image stored in said storage device to 1-bit data (Figures 1B and 1C; Column 9, Lines 24-58).

With regards to Claim 26, arguments analogous to those presented for Claim 24 are applicable to Claim 26.

Claim Rejections - 35 USC § 103

8. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

9. Claims 18 and 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Maruo (U.S. 6,292,583).

Regarding Claims 18 and 19, Maruo discloses wavelet transform of the input image (convolving the image by a plurality of filters, i.e., filtering in horizontal, diagonal and vertical directions) for outputting detailed information on image data (high-pass information which corresponds to the edge data; Column 7, Lines 46).

Maruo does not explicitly disclose the filters in the combination of filters are positioned along a circumferential line. However, it is well known that detected edges are the boundaries of patterns in the image which indicates that filtering is ultimately performed on the circumferential lines (Official Notice).

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It would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify Maruo's invention to position filters along a circumferential line because it is a standard procedure to recognize image contours or boundaries which will improve the accuracy of pattern recognition system.

Contact Information

10. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Mehrdad Dastouri whose telephone number is (703) 305-2438. The examiner can normally be reached on Monday to Friday from 8:00 a.m. to 4:30 p.m..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amelia Au can be reached on (703) 308-6604. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Mehrdad Dastouri
Primary Examiner
Art Unit 2623
February 21, 2005

**MEHRDAD DASTOURI
PRIMARY EXAMINER**

Mehrdad Dastouri